

7        wherein said first measuring device includes a first  
8        interferometer system, and said second measuring device  
9        includes a second interferometer system.

1        137. (Amended) A method according to claim 68,  
2        further comprising:  
3        measuring positional information of the first object;  
4        and  
5        measuring positional information of the second object,  
6        wherein said positional information of the first object  
7        includes positional information of said first object in a  
8        direction which crosses said first direction, and  
9        said positional information of the second object  
10      includes positional information of said second object in a  
11      direction which crosses said second direction.

1        138. (Amended) A method according to claim 68,  
2        further comprising:  
3        measuring positional information of the first object;  
4        and  
5        measuring positional information of the second object,  
6        wherein said positional information of the first object  
7        includes information on rotation of the first object; and  
8        said positional information of the second object  
9        includes information on rotation of the second object.